

October 1988 Revised August 1999

74F2243

Quad Bus Transceiver with 25 Ω Series Resistors in the Outputs

General Description

The 74F2243 is a quad bus transmitter/receiver which can be used for 4-line asynchronous 2-way data communications between data busses. It is designed to drive the capacitive inputs of MOS memory drivers, address drivers, clock drivers, and bus-oriented transmitters/receivers.

The 25Ω series resistors in the outputs reduce ringing and eliminate the need for external resistors.

Features

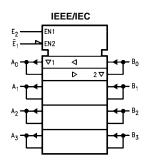
- 25 Ω series resistors in outputs eliminate the need for external resistors
- 2-Way asynchronous data bus communication
- 3-STATE outputs
- 12 mA source current
- Designed to drive the capacitive inputs of MOS devices

Ordering Code:

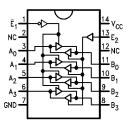
Order Number	Package Number	Package Description			
74F2243SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow			

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Truth Table

Inputs		Inputs/Outputs			
E ₁	E ₂	A _n	B _n		
L	L	Input	B = A		
L	Н	N/A	N/A		
Н	L	Z	Z		
Н	Н	A = B	Input		

H = HIGH Voltage Level L = LOW Voltage Level Z = High Impedance N/A = Not Allowed

Unit Loading/Fan Out

Pin Names	Description	U.L.	Input I _{IH} /I _{IL}		
Fill Names	Description	HIGH/LOW	Output I _{OH} /I _{OL}		
E ₁	Enable Input (Active LOW)	1.0/1.67	20 μA/–1 mA		
E ₂	Enable Input (Active HIGH)	1.0/1.67	20 μA/–1 mA		
A _n , B _n	Inputs	3.5/2.67	70 μA/–1.6 mA		
	Outputs	750/20	-15 mA/12 mA		

Absolute Maximum Ratings(Note 1)

Recommended Operating Conditions

 $\begin{array}{lll} \text{Storage Temperature} & -65^{\circ}\text{C to} + 150^{\circ}\text{C} \\ \text{Ambient Temperature under Bias} & -55^{\circ}\text{C to} + 125^{\circ}\text{C} \\ \text{Junction Temperature under Bias} & -55^{\circ}\text{C to} + 150\text{C} \\ \text{V}_{\text{CC}} \text{ Pin Potential to Ground Pin} & -0.5\text{V to} + 7.0\text{V} \\ \end{array}$

Voltage Applied to Output in HIGH State (with V_{CC} = 0V)

 $\begin{array}{ll} \mbox{Standard Output} & -0.5\mbox{V to V}_{\mbox{CC}} \\ \mbox{3-STATE Output} & -0.5\mbox{V to } +5.5\mbox{V} \end{array}$

Current Applied to Output

in LOW State (Max) ${\rm twice\ the\ rated\ I_{OL}\ (mA)}$ ESD Last Passing Voltage (Min) ${\rm 4000V}$

Free Air Ambient Temperature $0^{\circ}\text{C} \text{ to } +70^{\circ}\text{C}$ Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

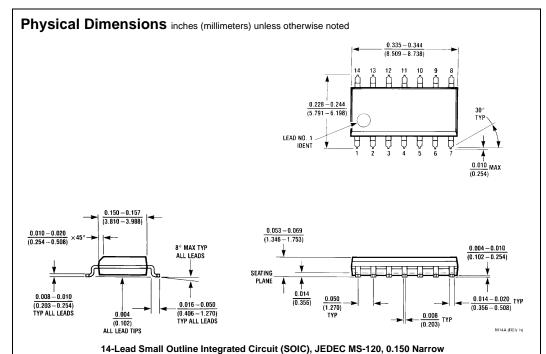
Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

Symbol	l Parameter		Min	Тур	Max	Units	V _{CC}	Conditions	
V _{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
V _{IL}	Input LOW Voltage				0.8	V		Recognized as a LOW Signal	
V _{CD}	Input Clamp Diode Voltag	ge			-1.2	V	Min	I _{IN} = -18 mA	
V _{OH}	Output HIGH	10% V _{CC}	2.4					$I_{OH} = -3 \text{ mA } (A_n, B_n)$	
	Voltage	10% V _{CC}	2.0			V	Min	$I_{OH} = -15 \text{ mA } (A_n, B_n)$	
		5% V _{CC}	2.7					$I_{OH} = -3 \text{ mA } (A_n, B_n)$	
V _{OL}	Output LOW				0.50	V	V Min	$I_{OL} = 1 \text{ mA } (A_n, B_n)$	
	Voltage				0.75	v		$I_{OL} = 12 \text{ mA } (A_n, B_n)$	
I _{IH}	Input HIGH Current				20	μΑ	Max	$V_{IN} = 2.7V (\overline{E}_1, \overline{E}_2)$	
I _{BVI}	Input HIGH Current Breakdown Test				100	μА	Max	v = 0.4 (= = 5.)	
								$V_{IN} = 7.0V (\overline{E}_1, E_2)$	
I _{BVIT}	Input HIGH Current				1.0	mA	Max	$V_{IN} = 5.5V (A_n, B_n)$	
	Breakdown Test (I/O)				1.0	mA	IVIAX	$V_{IN} = 5.5V (A_n, B_n)$	
I _{IL}	Input LOW Current				-1.0	mA	Max	$V_{IN} = 0.5V (\overline{E}_1, E_2)$	
I _{IH} + I _{OZH}	Output Leakage Current				70	μΑ	Max	$V_{OUT} = 2.7V (A_n, B_n)$	
I _{IL} + I _{OZL}	Output Leakage Current				-1.6	mA	Max	$V_{OUT} = 0.5V (A_n, B_n)$	
Ios	Output Short-Circuit Curr	ent	-100		-225	mA	Max	$V_{OUT} = 0V (A_n, B_n)$	
I _{CEX}	Output HIGH Leakage C	urrent			250	μΑ	Max	$V_{OUT} = V_{CC}$	
I _{CCH}	Power Supply Current			64	80	mA	Max	V _O = HIGH	
I _{CCL}	Power Supply Current			64	90	mA	Max	$V_O = LOW$	
I _{CCZ}	Power Supply Current			71	90	mA	Max	V _O = HIGH Z	

AC Electrical Characteristics

Symbol	Parameter	$T_{A} = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$			$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$ $C_L = 50$ pF		Units	
		Min	Тур	Max	Min	Max		
t _{PLH}	Propagation Delay	1.5		7.0	1.5	7.0	ns	
t _{PHL}	A_n to B_n , B_n to A_n	2.5		8.0	2.0	8.0	115	
t _{PZH}	Output Enable Time	1.5		9.0	1.0	9.5		
t _{PZL}	E ₁ to B _n , E ₂ to A _n	2.5		11.5	2.5	12.0	ns	
t _{PHZ}	Output Disable Time	1.5		9.0	1.0	9.5	115	
t _{PLZ}	\overline{E}_1 to B_n , E_2 to A_n	1.5		8.5	1.5	9.5		



Package Number M14A

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